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High Resolution High Resonance frequency Semicontact / Noncontact AFM Cantilevers HA_HR series with Pt conductive coating, each chip has 2 cantilevers, resonant frequency 380 kHz / 230 kHz, force constant 34 N/m / 17 N/m

Art. ID TIPS-HA_HR/Pt/200
Unit 200 separated chips

Deliverydetails No Dangerous Good /not restricted

Description

High Resolution High Resonant Frequency AFM Cantilevers HA_HR/Pt series are designed for Semicontact (Intermittent), Noncontact and electrical applications (SKM, SCM, SRIM, EFM, LAO Lithography). Each probe has 2 rectangular cantilevers. Typical Resonant Frequency 380kHz / 230kHz (dispersion ±10%), Typical Force Constant 34N/m / 17N/m (dispersion ±20%). Cantilever has Au reflective and Pt tip side coatings. Probes are also available without tip coating / Probes are packed in boxes with 15 and 50 pieces. Amount discount is included in the package price / High Accuracy composite ETALON probes combine the main features allowing to obtain high quality AFM images: Sharp tip - curvature radius < 10 nm./// Resonance frequency, specified with high accuracy - ±10% within a wafer./// Special chip geometry with vertical sidewalls for convenient operating./// High aspect ratio tip./// Enhanced back-side reflection of the cantilever./// Cost effective price